

|                                   |  |                         |   |             |
|-----------------------------------|--|-------------------------|---|-------------|
| <b>Notice of References Cited</b> |  | Application/Control No. | Applicant(s)/Patent Under Reexamination |             |
|                                   |  | 10/670,112              | WHEELER ET AL.                          |             |
| Examiner                          |  | Art Unit                |   | Page 1 of 2 |
| Yaritza Guadalupe McCall          |  | 2859                    |   |             |

**U.S. PATENT DOCUMENTS**

| * | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Name                | Classification |
|---|--|-----------------|---------------------|----------------|
| A | US-2004/0123472                                  | 07-2004         | Wu, Shuming         | 033/286        |
| B | US-6,253,670                                     | 07-2001         | Gingras, Michel     | 99/589         |
| C | US-5,367,779                                     | 11-1994         | Lee, Roger          | 33/290         |
| D | US-2004/0221462                                  | 11-2004         | Liao, Wen Shin      | 033/286        |
| E | US-6,880,256                                     | 04-2005         | Helms, David B.     | 33/286         |
| F | US-5,218,770                                     | 06-1993         | Toga, Noriyuki      | 33/276         |
| G | US-6,829,834                                     | 12-2004         | Krantz, Norman      | 33/286         |
| H | US-6,502,319                                     | 01-2003         | Goodrich et al.     | 33/286         |
| I | US-6,577,388                                     | 06-2003         | Kallabis, Gabriel   | 356/139.1      |
| J | US-4,993,161                                     | 02-1991         | Borkovitz, Henry S. | 33/291         |
| K | US-6,808,090                                     | 10-2004         | Pedersen, Oeyvind   | 222/181.3      |
| L | US-3,988,837                                     | 11-1976         | Benson, George E.   | 33/227         |
| M | US-6,427,347                                     | 08-2002         | Butler, Sr., Roy    | 33/286         |

**FOREIGN PATENT DOCUMENTS**

| * | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Country | Name | Classification |
|---|--|-----------------|---------|------|----------------|
| N |  |                 |         |      |                |
| O |  |                 |         |      |                |
| P |  |                 |         |      |                |
| Q |  |                 |         |      |                |
| R |  |                 |         |      |                |
| S |  |                 |         |      |                |
| T |  |                 |         |      |                |

**NON-PATENT DOCUMENTS**

| * | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |  |  |
|---|---|--|--|
| U |   |  |  |
| V |   |  |  |
| W |   |  |  |
| X |   |  |  |

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

**Notice of References Cited**

 Application/Control No.  
 10/670,112

 Applicant(s)/Patent Under  
 Reexamination  
 WHEELER ET AL.

 Examiner  
 Yaritza Guadalupe McCall

 Art Unit  
 2859  
 Page 2 of 2

**U.S. PATENT DOCUMENTS**

| * | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Name                   | Classification |
|---|--|-----------------|------------------------|----------------|
| A | US-6,035,540                                     | 03-2000         | Wu et al.              | 33/286         |
| B | US-5,782,003                                     | 07-1998         | Bozzo, Mario Doriguzzi | 33/291         |
| C | US-  |                 |                        |                |
| D | US-  |                 |                        |                |
| E | US-  |                 |                        |                |
| F | US-  |                 |                        |                |
| G | US-  |                 |                        |                |
| H | US-  |                 |                        |                |
| I | US-  |                 |                        |                |
| J | US-  |                 |                        |                |
| K | US-  |                 |                        |                |
| L | US-  |                 |                        |                |
| M | US-  |                 |                        |                |

**FOREIGN PATENT DOCUMENTS**

| * | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Country | Name | Classification |
|---|--|-----------------|---------|------|----------------|
| N |  |                 |         |      |                |
| O |  |                 |         |      |                |
| P |  |                 |         |      |                |
| Q |  |                 |         |      |                |
| R |  |                 |         |      |                |
| S |  |                 |         |      |                |
| T |  |                 |         |      |                |

**NON-PATENT DOCUMENTS**

| * | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |  |  |
|---|---|--|--|
| U |   |  |  |
| V |   |  |  |
| W |   |  |  |
| X |   |  |  |

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.